Se	arcn Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/807,223	ARAI, TAKEO	
Examiner	Art Unit	_
Leonard S. Liang	2853	

	SEAR	CHED	
Class	Subclass	Date	Examiner
347	102	3/3/2007	LSL
347	101		
101	488		
219	216		
399	320		
347	5		
347	9	V	Ψ

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
347	102	3/3/2007	LSL	
347	101			
347	9	- V		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
(DATE	EXMR	
03/03/07 Claim Tree	3/3/2007	LSL	
03/03/07 Update and Interference Search			
B41J002/01.ipc; B41J029/38.ipc. with text search (See Update and Interference Search)	V		